Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/044,195	SYED, MAJID
Examiner	Art Unit
Thuong (Tina) T. Nguyen	2155

	SEARCHED		
Class	Subclass	Date	Examiner
709	225,226, 231	3/17/2006	тн
725	86	3/17/2006	TH
			,
			,

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	1			

S (INCLUDIN	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST	3/17/2006	тн	
IEEE	3/17/2006	тн	
·			
•			